Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/710,828	EDELSTEIN ET AL.	
Examiner	Art Unit	
Marcos D. Pizarro-Crespo	2814	

SEARCHED					
Class	Subclass	Date	Examiner		
257	750-766	1/27/2006	MDP		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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